

## Features

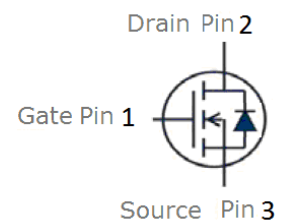
- Enhancement mode
- Low on-resistance  $R_{DS(on)}$  @  $V_{GS}=4.5\text{ V}$
- VitoMOS<sup>®</sup> II Technology
- Fast Switching and High efficiency
- 100% Avalanche Tested
- Pb-free lead plating; RoHS compliant



Part ID	Package Type	Marking	Tape and reel information
VSI004N10MS-G	TO-251	004N10M	75pcs/Tube

$V_{DS}$	100	V
$R_{DS(on),TYP} @ V_{GS}=10\text{ V}$	4.5	m $\Omega$
$R_{DS(on),TYP} @ V_{GS}=4.5\text{ V}$	7.0	m $\Omega$
$I_D$	130	A

TO-251



## Maximum ratings, at $T_A = 25^\circ\text{C}$ , unless otherwise specified

Symbol	Parameter	Rating	Unit
$V_{(BR)DSS}$	Drain-Source breakdown voltage	100	V
$V_{GS}$	Gate-Source voltage	$\pm 20$	V
$I_S$	Diode continuous forward current	$T_C = 25^\circ\text{C}$	130 A
$I_D$	Continuous drain current @ $V_{GS}=10\text{V}$	$T_C = 25^\circ\text{C}$	130 A
		$T_C = 100^\circ\text{C}$	92 A
$I_{DM}$	Pulse drain current tested ①	$T_C = 25^\circ\text{C}$	520 A
$I_{DSM}$	Continuous drain current @ $V_{GS}=10\text{V}$	$T_A = 25^\circ\text{C}$	12 A
		$T_A = 70^\circ\text{C}$	9 A
EAS	Avalanche energy, single pulsed ②	100	mJ
$P_D$	Maximum power dissipation	$T_C = 25^\circ\text{C}$	158 W
$P_{DSM}$	Maximum power dissipation ③	$T_A = 25^\circ\text{C}$	1.3 W
$T_{STG}, T_J$	Storage and Junction Temperature Range	-55 to 175	$^\circ\text{C}$

## Thermal Characteristics

Symbol	Parameter	Typical	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	0.95	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	100	$^\circ\text{C/W}$

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
<b>Static Electrical Characteristics @ T<sub>j</sub>=25°C (unless otherwise stated)</b>						
V <sub>(BR)DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA	100	--	--	V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =100V, V <sub>GS</sub> =0V	--	--	1	μA
	Zero Gate Voltage Drain Current(T <sub>j</sub> =125°C)	V <sub>DS</sub> =100V, V <sub>GS</sub> =0V	--	--	100	μA
I <sub>GSS</sub>	Gate-Body Leakage Current	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V	--	--	±100	nA
V <sub>GS(TH)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	1.4	1.9	2.5	V
R <sub>DS(ON)</sub>	Drain-Source On-State Resistance ④	V <sub>GS</sub> =10V, I <sub>D</sub> =75A	--	4.5	6.5	mΩ
		T <sub>j</sub> =100°C	--	5.7	--	mΩ
R <sub>DS(ON)</sub>	Drain-Source On-State Resistance ④	V <sub>GS</sub> =4.5V, I <sub>D</sub> =65A	--	7	9	mΩ
<b>Dynamic Electrical Characteristics @ T<sub>j</sub> = 25°C (unless otherwise stated)</b>						
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =30V, V <sub>GS</sub> =0V, f=1MHz	3585	4215	4845	pF
C <sub>oss</sub>	Output Capacitance		1360	1600	1840	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		25	35	45	pF
R <sub>g</sub>	Gate Resistance	f=1MHz	--	1	--	Ω
Q <sub>g</sub> (10V)	Total Gate Charge	V <sub>DS</sub> =50V, I <sub>D</sub> =50A, V <sub>GS</sub> =10V	--	56	--	nC
Q <sub>g</sub> (4.5V)	Total Gate Charge		--	27	--	nC
Q <sub>gs</sub>	Gate-Source Charge		--	14	--	nC
Q <sub>gd</sub>	Gate-Drain Charge		--	7.2	--	nC
<b>Switching Characteristics</b>						
t <sub>d(on)</sub>	Turn-on Delay Time	V <sub>DD</sub> =50V, I <sub>D</sub> =50A, R <sub>G</sub> =3Ω, V <sub>GS</sub> =10V	--	14	--	ns
t <sub>r</sub>	Turn-on Rise Time		--	57	--	ns
t <sub>d(off)</sub>	Turn-Off Delay Time		--	41	--	ns
t <sub>f</sub>	Turn-Off Fall Time		--	76	--	ns
<b>Source- Drain Diode Characteristics @ T<sub>j</sub> = 25°C (unless otherwise stated)</b>						
V <sub>SD</sub>	Forward on voltage	I <sub>SD</sub> =75A, V <sub>GS</sub> =0V	--	0.9	1.2	V
t <sub>rr</sub>	Reverse Recovery Time	T <sub>j</sub> =25°C, I <sub>sd</sub> =50A, V <sub>GS</sub> =0V	--	61	--	ns
Q <sub>rr</sub>	Reverse Recovery Charge	di/dt=100A/μs	--	86	--	nC

NOTE:

- ① Repetitive rating; pulse width limited by max junction temperature.
- ② Limited by T<sub>Jmax</sub>, starting T<sub>J</sub> = 25°C, L = 0.5mH, R<sub>G</sub> = 25Ω, I<sub>AS</sub> = 20A, V<sub>GS</sub> = 10V. Part not recommended for use above this value
- ③ The power dissipation P<sub>DSM</sub> is based on R<sub>θJA</sub> and the maximum allowed junction temperature of 150°C.
- ④ Pulse width ≤ 380μs; duty cycle ≤ 2%.



Typical Characteristics

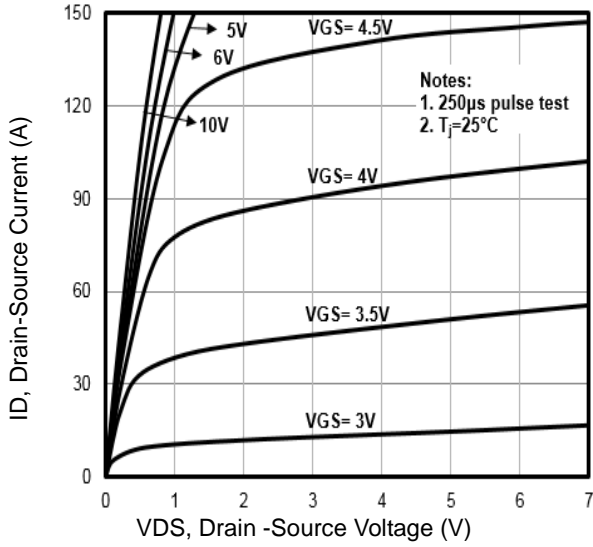


Fig1. Typical Output Characteristics

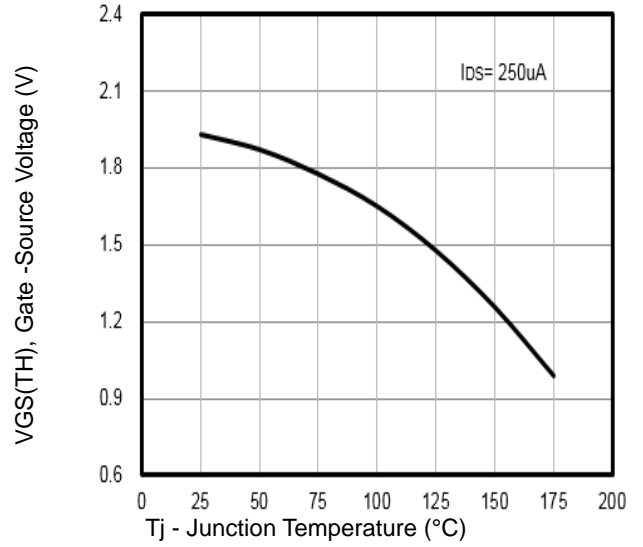


Fig2. V<sub>GS(TH)</sub> Gate-Source Voltage Vs. T<sub>J</sub>

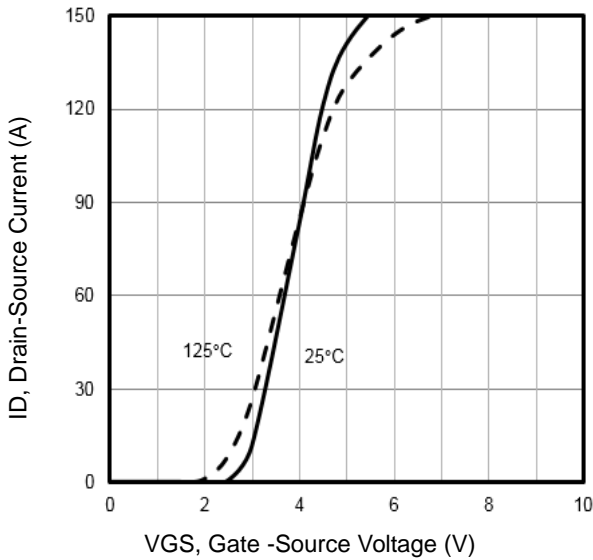


Fig3. Typical Transfer Characteristics

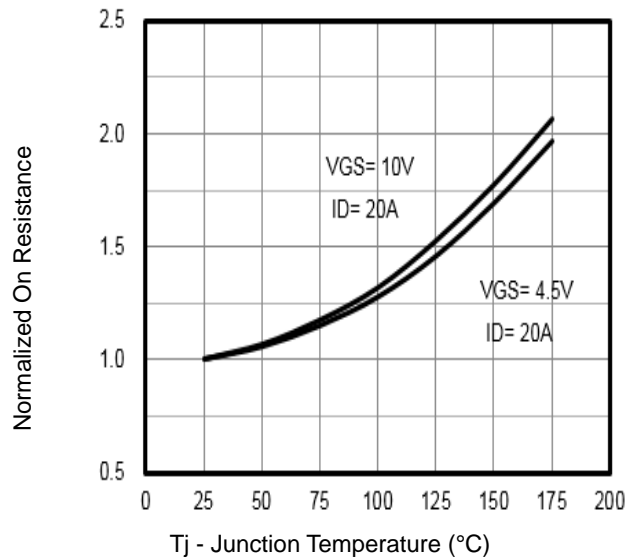


Fig4. Normalized On-Resistance Vs. T<sub>J</sub>

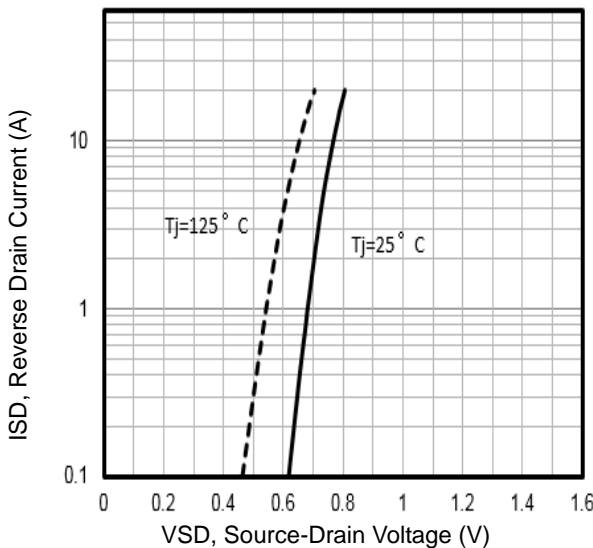


Fig5. Typical Source-Drain Diode Forward Voltage

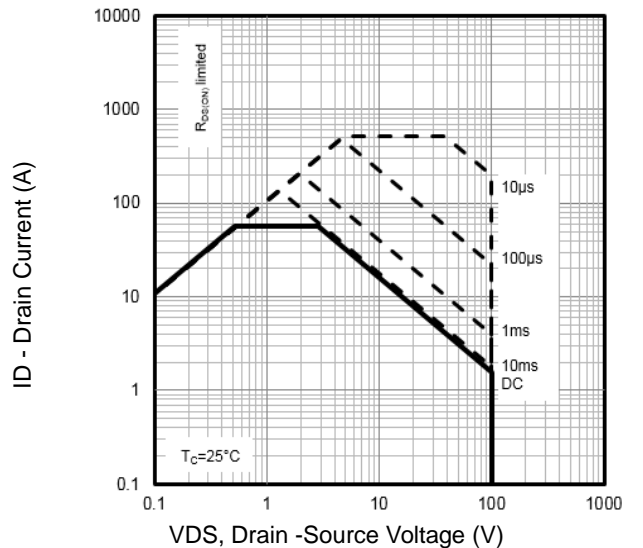


Fig6. Maximum Safe Operating Area

Typical Characteristics

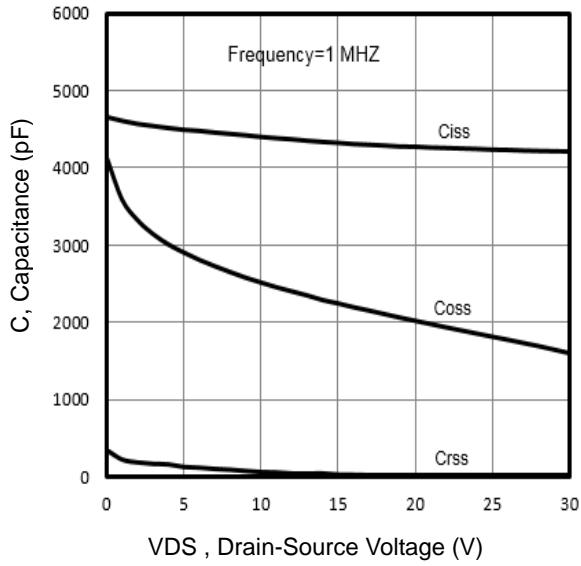


Fig7. Typical Capacitance Vs.Drain-Source Voltage

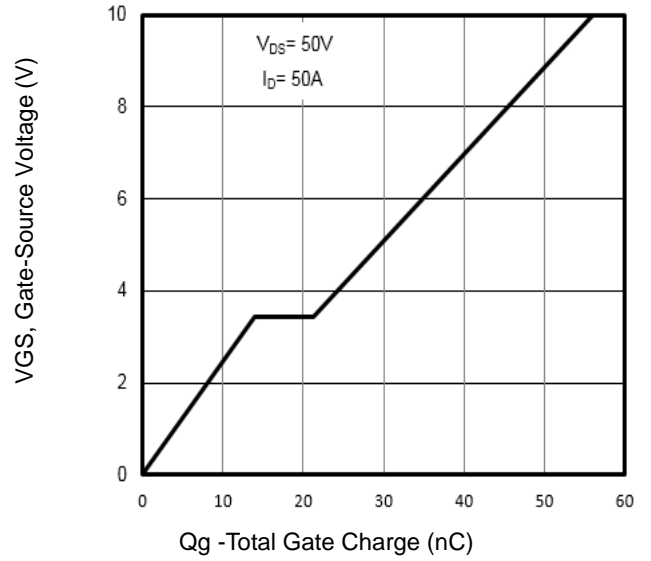


Fig8. Typical Gate Charge Vs.Gate-Source Voltage

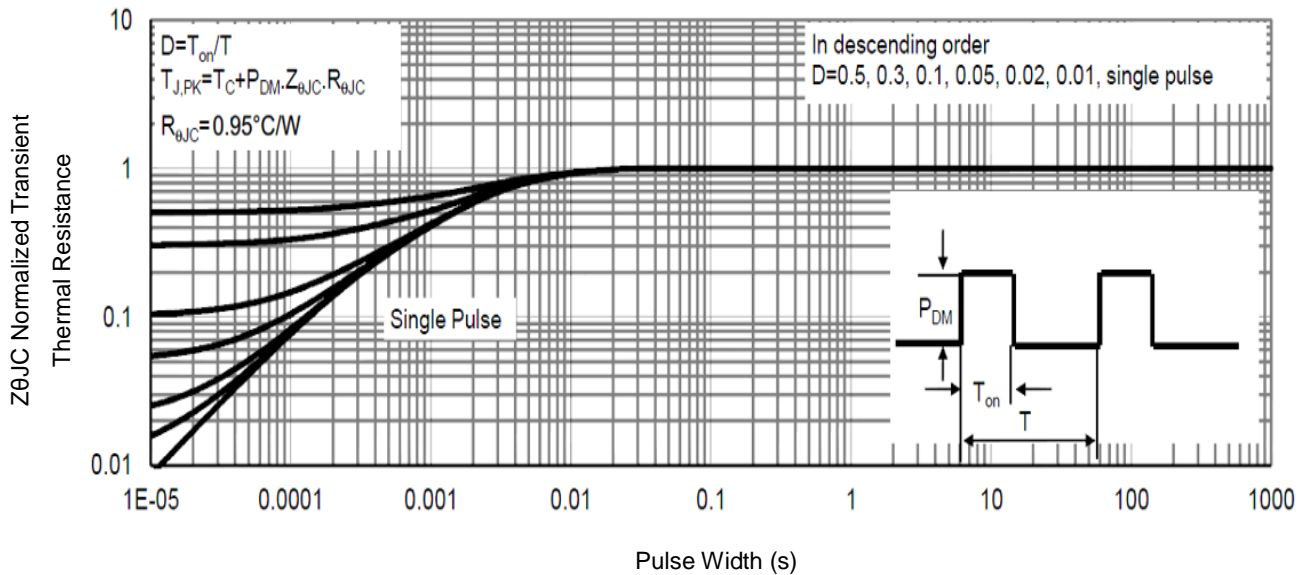


Fig9. Normalized Maximum Transient Thermal Impedance

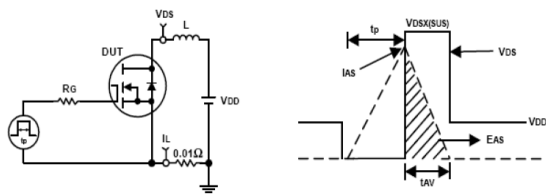


Fig10. Unclamped Inductive Test Circuit and waveforms

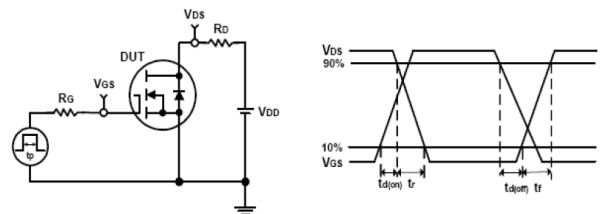
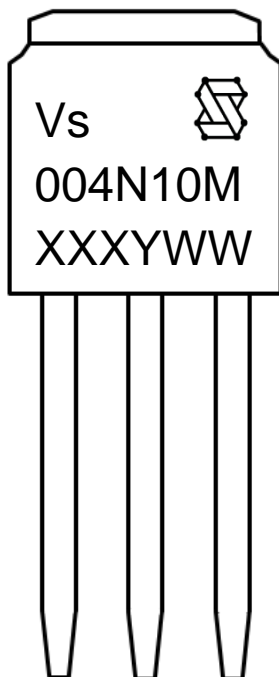


Fig11. Switching Time Test Circuit and waveforms

## Marking Information



1st line: Vanguard Code (Vs), Vanguard Logo

2nd line: Part Number (004N10M)

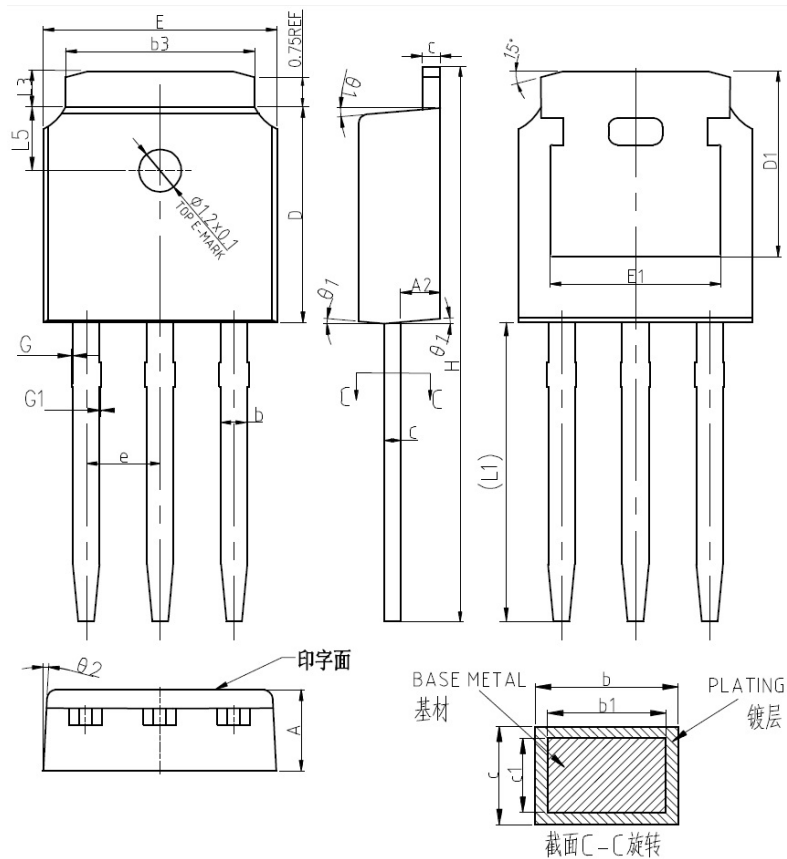
3rd line: Date code (XXXYWW)

XXX: Wafer Lot Number Code , code changed with Lot Number

Y: Year Code, (e.g. E=2017, F=2018, G=2019, H=2020, etc)

WW: Week Code (01 to 53)

### TO-251 Package Outline Data



Symbol	Dimensions (unit: mm)		
	Min	Typ	Max
A	2.20	2.30	2.38
A2	0.97	1.07	1.17
b	0.72	0.78	0.85
b1	0.71	0.76	0.81
b3	5.23	5.33	5.46
c	0.47	0.53	0.58
c1	0.46	0.51	0.56
D	6.00	6.10	6.20
D1	5.30 REF		
E	6.50	6.60	6.70
E1	4.70	4.83	4.92
e	2.286 BSC		
G	0.00	0.04	0.10
G1	0.00	0.04	0.10
H	16.22	16.52	16.82
L1	9.20	9.40	9.60
L3	0.90	1.02	1.25
L5	1.70	1.80	1.90
$\theta 1$	5°	7°	9°
$\theta 2$	5°	7°	9°

#### Notes:

1. Refer to JEDEC TO-251 variation AA
2. Dimension "D" and "E" do NOT include mold flash. Mold flash shall not exceed 0.127mm per side.

### Customer Service

Sales and Service:

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